

[54] ULTRASONIC WAVE THICKNESS METER

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[52] U.S. Cl. .... D10/46; D10/78  
[58] Field of Search ..... D10/46, 75, 78, 47; 73/597, 431, 432 R

[56]

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D. 213,962	4/1969	Potruch .....	D10/78
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OTHER PUBLICATIONS

*Krautkramer*-Brochure-2/76-D-Meter Wall Thickness Gauge.

*Metrifast*-Flyer-5/24/77-Metal Detector.

*Product Engineering*-10/78-p. 106-Thickness Gauge at top left.

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[57]

CLAIM

The ornamental design for an ultrasonic wave thickness meter, as shown and described.

DESCRIPTION

FIG. 1 is a front elevational view of an ultrasonic wave thickness meter showing our new design;

FIG. 2 is a rear elevational view thereof;

FIG. 3 is a right side elevational view thereof;

FIG. 4 is a left side elevational view thereof;

FIG. 5 is a top plan view thereof; and

FIG. 6 is a bottom plan view thereof.

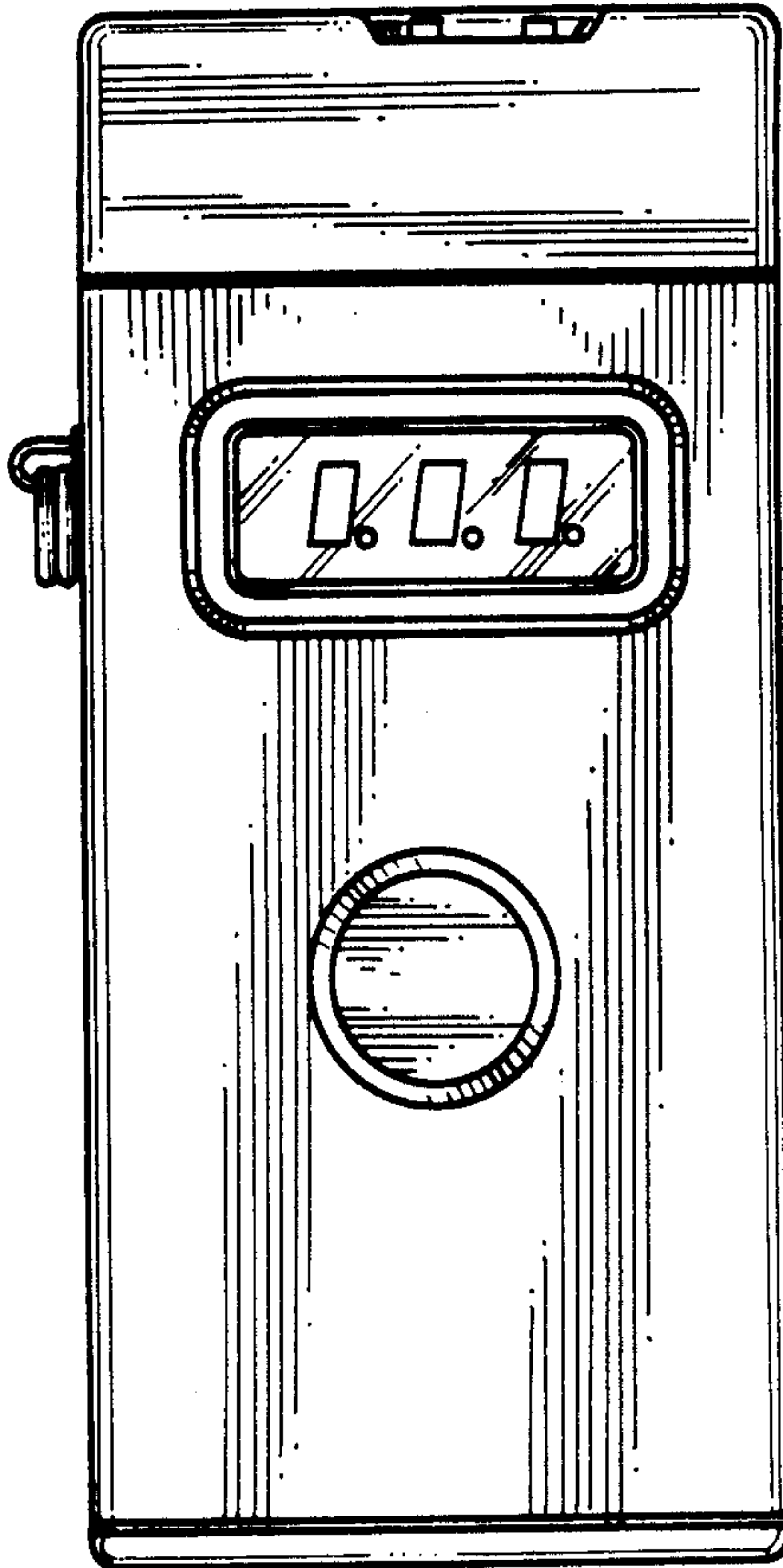


FIG. 1

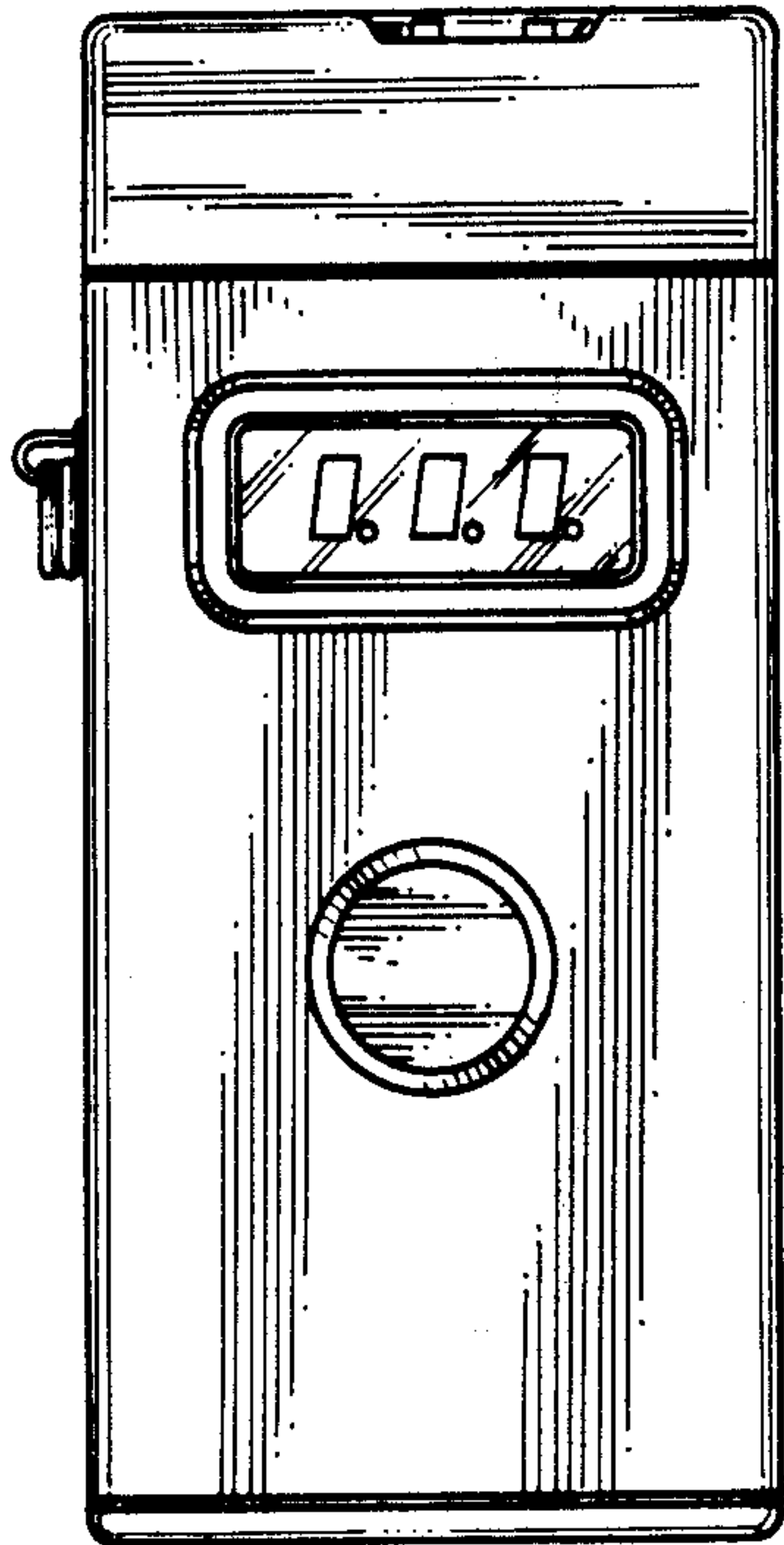


FIG. 2

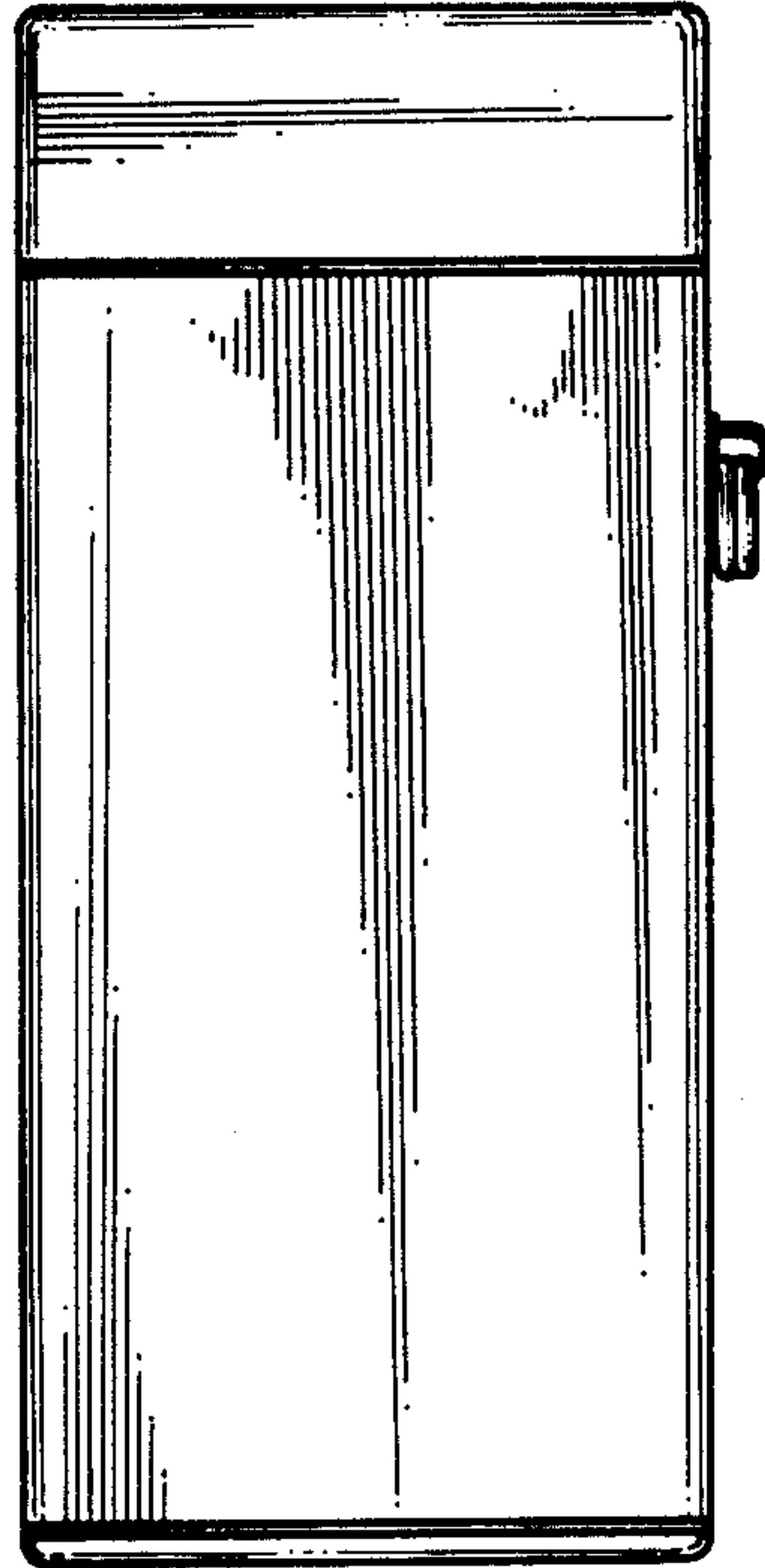


FIG. 3

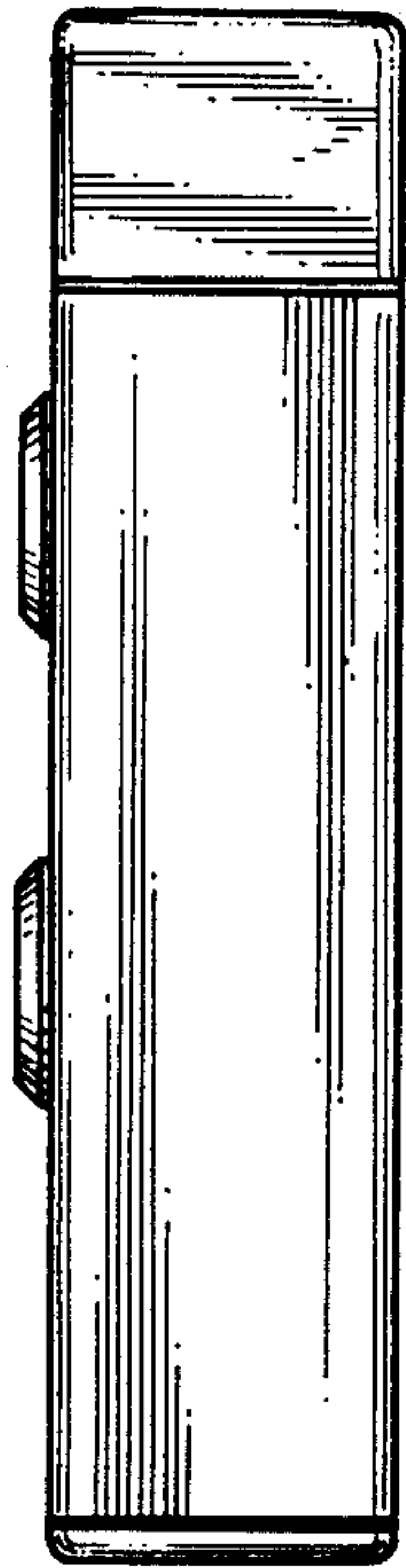


FIG. 4

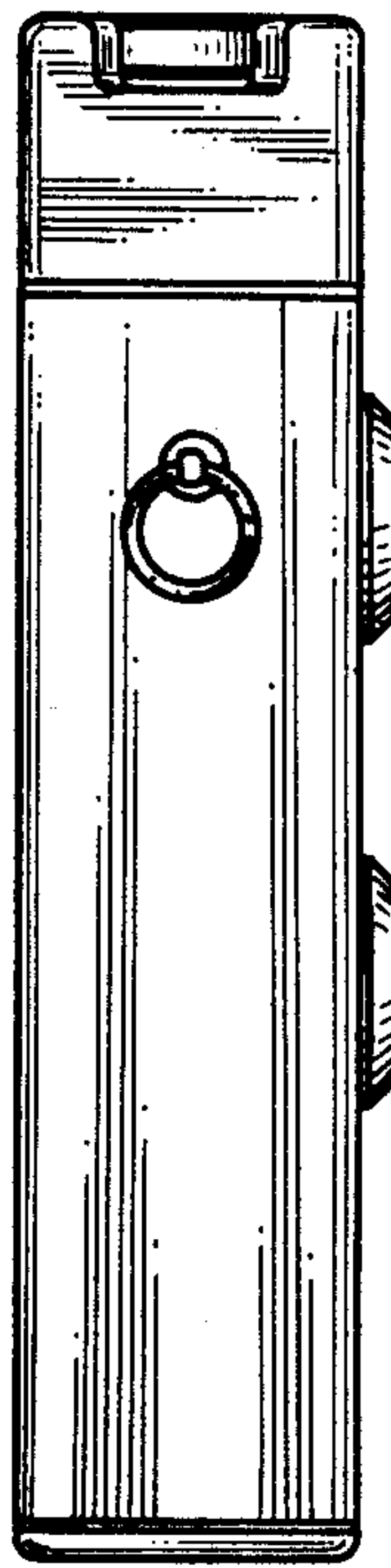


FIG. 5

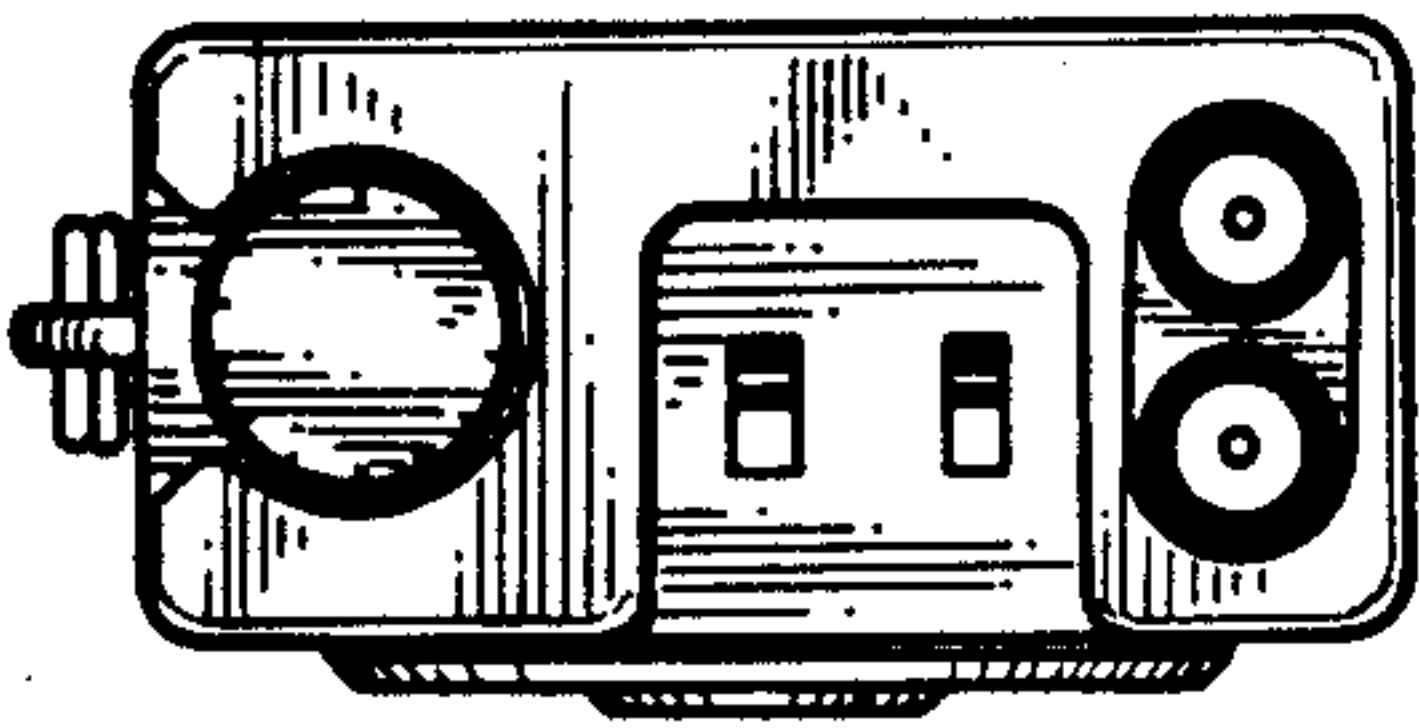


FIG. 6

